

IEEE Guide for General Principles of Reliability Analysis of Nuclear Power Generating Station Systems and Other Nuclear Facilities

IEEE Power and Energy Society

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**Nuclear Power Engineering Committee
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IEEE Power and Energy Society**

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Abstract: General reliability and availability analysis methods that can be applied to structures, systems, and components (SSCs) in nuclear power generating stations and other nuclear facilities are contained in this guide.

Keywords: availability, Class 1E, failure rate, IEEE 352™, MTBF, MTTF, MTTR, nuclear power generating station, reliability

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Introduction

This introduction is not part of IEEE Std 352-2016, IEEE Guide for General Principles of Reliability Analysis of Nuclear Power Generating Station Systems and Other Nuclear Facilities.

This document is basically tutorial and has been prepared to provide the user with the basic principles that are needed to conduct a reliability analysis of safety systems. It is not expected or intended that any individual or organization would need all of the principles that are presented. For example, an organization may be concerned with quantitative analysis and mathematical modeling as discussed in [Clause 6](#). The very important problem of failure data is discussed in [Clause 7](#); the material on probability distributions, estimation, and confidence intervals may be used by those who are concerned with analysis and evaluation of failure and repair rate data that will be accumulated as nuclear power generating station operating experience is accrued. The material on established data programs may be of more immediate use to those who make reliability or availability predictions on current safety system designs.

This document was originally prepared to provide a common and consistent means of reliability analysis for protection systems covered by IEEE Std 279™-1971, IEEE Standard: Criteria for Protection Systems for Nuclear Power Generating Stations. In the intervening years, IEEE Std 279 has been superseded by IEEE Std 603™, and in March, 1984, IEEE Std 279 was withdrawn. This standard has been expanded in revisions since 1971 to include many technical areas as they have become important. In accord with the current version of IEEE Std 603, it has been generalized to apply to safety systems.

The general principles presented in this document, and further information given by the references, are sufficient to conduct the reliability/availability analyses of safety systems, but not every analysis will necessarily employ all of the general principles that are presented. Furthermore, the principles contained herein are not necessarily limited to nuclear power plant safety systems. They may be applied to the analyses of other facilities and systems by selecting those parts of the principles relevant to those other facilities/systems.

The current revision of this document contains much updated information and clarification, but adheres to the general principles put forth in previous editions.

Contents

1. Overview	12
1.1 General	12
1.2 Scope	12
1.3 Purpose	13
2. Normative references.....	13
3. Definitions, acronyms, and abbreviations	13
3.1 Definitions	13
3.2 Acronyms and abbreviations	15
4. Objectives and methods.....	15
4.1 Overview	15
4.2 Consideration of the human factor.....	15
4.3 Qualitative analysis.....	16
4.3.1 Objectives of a qualitative analysis.....	16
4.3.2 Steps in a qualitative analysis	16
4.4 Quantitative analysis.....	17
4.5 Applications of reliability methodology	17
4.5.1 Overview.....	17
4.5.2 Failure modes and effects analysis (FMEA).....	17
4.5.3 Logic trees.....	18
4.5.4 System modeling.....	18
4.5.5 Reliability testing	19
5. Qualitative analysis principles.....	20
5.1 Overview	20
5.2 Failure modes and effects analysis (FMEA).....	20
5.2.1 Purposes of failure modes and effects analysis (FMEA)	20
5.2.2 Timing of a failure mode and effects analysis (FMEA).....	23
5.2.3 Issues addressed in a failure mode and effects analysis (FMEA)	23
5.2.4 Preparatory steps for a failure mode and effects analysis (FMEA).....	24
5.2.5 Procedure for a failure mode and effects analysis (FMEA).....	24
5.3 Fault tree analysis	25
5.3.1 Functions and benefits of fault tree analysis	27
5.3.2 Representation of events and operations in a fault tree.....	28
5.3.3 Procedure for constructing a fault tree	30
5.4 Reliability block diagram (RBD).....	31
5.4.1 Reliability block diagram (RBD) construction	32
5.4.2 Reliability block diagram (RBD) reduction.....	32
5.4.3 Comparison of fault tree and reliability block diagrams (RBDs).....	32
5.5 Example.....	33
5.5.1 Description of a typical reactor trip function	33
5.5.2 Failure mode and effects analysis (FMEA).....	33
5.5.3 Fault tree analysis	33
5.5.4 Reliability block diagram (RBD).....	33
5.6 Extended qualitative analysis for common-cause failures	34
5.6.1 Extended failure mode and effect analysis (FMEA).....	38
5.6.2 Extended fault tree analysis	39
5.6.3 Termination of the analyses	39
6. Quantitative analysis principles.....	40

6.1 Overview	40
6.2 Mission definition.....	40
6.2.1 Reliability.....	40
6.2.2 Availability (steady-state).....	42
6.3 Mathematical modeling	43
6.3.1 Manual calculation.....	44
6.3.2 For computer calculation	57
6.4 Tabular reference to popular logic configurations.....	60
6.5 Trial calculations	61
6.5.1 Manual calculations	61
6.5.2 Computer calculations.....	61
6.6 Credibility check of results.....	61
6.6.1 Comparison with prior analysis	61
6.6.2 Sensitivity analysis.....	61
7. Guides for data acquisition and use.....	63
7.1 Overview	63
7.2 Input parameters	64
7.2.1 Failure rates.....	64
7.2.2 Mean time to repair (MTTR)	64
7.2.3 Mission time.....	65
7.2.4 Test interval	65
7.2.5 Test schedule.....	65
7.3 Probability distributions, parameters, and estimation.....	65
7.3.1 Exponential distribution.....	67
7.3.2 Poisson distribution.....	70
7.3.3 Binomial distribution	71
7.3.4 Weibull distribution	72
7.3.5 Combining and updating data	73
7.4 Established data programs	73
7.4.1 Failure Rate Data Program (FARADA).....	74
7.4.2 Government-Industry Data Exchange Program (GIDEP).....	74
7.4.3 Nonelectric parts reliability data (NPRD-1).....	74
7.4.4 Energy Technology Engineering Center (ETEC)	75
7.4.5 United Kingdom Atomic Energy Authority Data Program (UKAEA), National Center of Systems Reliability (SYREL).....	75
7.4.6 Nuclear Plant Reliability Data System (NPRDS)	75
7.4.7 Generating Availability Data System (GADS)	76
7.4.8 Licensee event reports.....	76
7.4.9 Operating Units Status Report (NUREG-0020).....	77
7.4.10 Reactor Safety Study, WASH-1400 (NUREG-75/01 4)	77
7.4.11 Failure Incident Report Review (FIRR).....	77
7.4.12 IEEE Survey of Industrial and Commercial Power Systems	77
7.4.13 Nuclear power experience reports.....	77
7.4.14 IEEE Nuclear Reliability Data Manual—IEEE Std 500™ [B22].....	78
7.5 Developing field data programs.....	78
7.5.1 Failure analysis	79
7.5.2 Failure data analysis.....	81
8. Application of reliability methods.....	84
8.1 Introduction	84
8.2 Numerical goals.....	84
8.2.1 Basis for establishing numerical goals	84
8.2.2 Specific goals	85
8.2.3 Procedures.....	86
8.3 Selection of the modeling technique.....	86

8.3.1 Model requirements	86
8.3.2 Model limitations	86
8.4 Fault tree techniques	87
8.4.1 Characteristics	87
8.4.2 Recommended uses	88
8.5 The Markov process as a reliability model	88
8.5.1 Constant failure and repair rate components	91
8.5.2 Constant repair or switching time components	91
8.5.3 Constant success/failure on demand	92
8.6 Monte Carlo techniques	92
8.6.1 Characteristics	92
8.6.2 Recommended uses	93
8.7 Equipment and system testing	93
8.7.1 Acceptance sampling	93
8.7.2 Initial test intervals	98
8.7.3 In-service adjustment of test intervals	100
Annex A (informative) Bibliography	101
Annex B (informative) Illustration of concepts and methods of reliability and availability analyses	104
B.1 Introduction	104
B.2 Procedure	104
B.2.1 System definition	104
B.2.2 Failure mode and effects analysis (FMEA) (qualitative analysis)	105
B.2.3 Common-cause-failure analysis	105
B.2.4 Reliability/Availability prediction (quantitative)	105
B.3 Illustrative examples	105
B.3.1 System definition	105
B.3.2 Qualitative analysis—failure modes and effects analysis (FMEA)	107
B.3.3 Common-cause-failure analysis	127
B.3.4 Quantitative analysis	131
Annex C (informative) Mean time to repair (MTTR) process	148
C.1 Introduction	148
C.1.1 Call-out	148
C.1.2 Briefing	148
C.1.3 Access control	148
C.1.4 Establishing prerequisite conditions	148
C.1.5 Troubleshooting	149
C.1.6 Spare parts acquisition	149
C.1.7 Pre-configuration	149
C.1.8 Disassembly	149
C.1.9 Re-assembly	149
C.1.10 Inspections	149
C.1.11 Post-configuration	150
C.1.12 Test	150
C.2 Systematic mean time to repair (MTTR) estimation method	150
C.3 A sample mean time to repair (MTTR) estimation	152

IEEE Guide for General Principles of Reliability Analysis of Nuclear Power Generating Station Systems and Other Nuclear Facilities

1. Overview

1.1 General

This guide was prepared to provide the designers and operators of nuclear power plant safety systems and concerned regulatory groups with the essential methods and procedures of reliability engineering that are applicable to such systems. By applying the principles given, systems may be analyzed, results may be compared with reliability objectives, and the basis for decisions may be suitably documented.

The quantitative principles are applicable to the analysis of the effects of component failures on safety system reliability. The principles are applicable during any phase of the system's lifetime. They have their greatest value during the design phase. During this phase, reliability engineering can make the greatest contribution toward enhancing safety.

These principles may also be applied during the preoperational phase or at any time during the normal lifetime of a system. When the principles are applied during either of these two phases, they will aid in the evaluation of systems, in the preparation or revision of operating or maintenance procedures, and in improving test programs. Although not inherently limited, these principles are intended for application to systems covered in the scope of IEEE Std 603™ [B24].¹

1.2 Scope

This guide contains general reliability and availability analysis methods that can be applied to structures, systems, and components (SSCs) in nuclear power generating stations and other nuclear facilities.

¹The numbers in brackets correspond to those of the references listed in the bibliography in [Annex A](#).